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INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Application No.	09/970,087
				Filing Date	October 2, 2001
				First Named Inventor	Sobha Pisharody
				Art Unit	1634
				Examiner Name	Jeffrey Norman Fredman
Sheet	1	of	1	Attorney Docket Number	24171-08815

U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No. ¹	Document No. Number – Kind Code ² (if known)	Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		US-		
		US-		
		US-		

FOREIGN PATENT DOCUMENTS				
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ – Number ⁴ Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
				T ⁶

OTHER REFERENCES – NON-PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published		
/	CD	BEZRYADIN, ET AL. Electrostatic trapping of single conducting nanoparticles between nonoelectrodes; Appl. Phys. Lett. 71 (9); September 1, 1997, p. 1273-1275		
/	CE	BRAUN, ET AL., DNA-templated assembly and electrode attachment of a conducting silver wire; Nature, Vol. 391, February 19, 1998, p. 775-778		
/	CF	FINK, DNA and conducting electrons; CMLS, Cell. Mol. Life Sci. 58 (2001) 1-3		
/	CG	RICHTER, Metallization of DNA; Physica E 16 (2003) 157-173		

Examiner Signature		Date Considered	01/20/01
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24171-01000/SF/5115213.1



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LIST OF REFERENCES CITED BY APPLICANT
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11210-010-999

APPLICATION NO.

09/970,087

APPLICANT

Pisharody et al.

FILING DATE

October 2, 2001

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